



Universität
Münster



Certified machine learning for model order reduction of parametrized problems

Ulysses Research Workshop on Mathematics in Machine Learning

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Parametrized problems – Some examples

- Parabolic partial differential equations
- Optimal control problems

Reduced basis methods and residual-based error estimates

- Projection-based reduced order models
- A posteriori error estimation

Machine learning in model order reduction

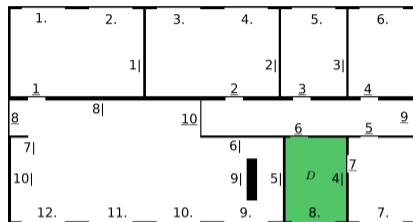
- Surrogate building on a reduced basis reduced model
- Certification using a posteriori error estimates

Adaptive model hierarchies combining multiple models

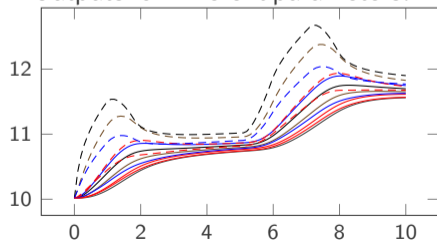
Numerical experiments and results

Parametrized problems – Some examples

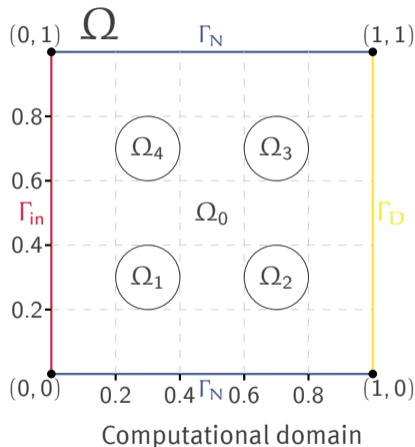
- ▶ **Parametrized** diffusion coefficient and right-hand side (heaters, walls, doors)
- ▶ Average temperature in the childcare room D as **output**
- ▶ Goal: **Monte Carlo estimation** of expectation and variance of output quantity over the parameter space



Outputs for different parameters:



- ▶ **Parametrized** state equation (cookie dough)
- ▶ Control acting on the inflow boundary
- ▶ Average temperature in cookies as **output** quantities
- ▶ Goal: Find control minimizing sum of distance to a target output and control energy



Reduced basis methods and residual-based error estimates

- ▶ Linear parametrized problem (after suitable discretization etc.):

$$\boxed{A(\mu) \mathbf{y}_\mu = \mathbf{f}(\mu)} \quad \leftarrow \text{large linear system}$$

where the solution $\mathbf{y}_\mu \in X$ is **high-dimensional**.

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- ▶ Idea: Replace X by low-dimensional subspace $X^N \subset X$ and project system onto X^N :

$$\boxed{\hat{A}(\mu) \mathbf{y}_\mu^N = \hat{\mathbf{f}}(\mu)} \quad \leftarrow \text{small linear system}$$

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- ▶ Representation of the reduced solution in a reduced basis $\mathbf{x}_1, \dots, \mathbf{x}_N \in X^N$:

$$\mathbf{y}_\mu^N = \sum_{i=1}^N \alpha_i(\mu) \mathbf{x}_i$$

- ▶ Consider residual of the original system for an approximate solution $\tilde{y} \in X^N$:

$$\eta_{\mu}(\tilde{y}) := c \cdot \underbrace{\|A(\mu)\tilde{y} - f(\mu)\|}_{\text{defect in the linear system}}$$

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- ▶ Key observation: The estimate works for all $\tilde{y} \in X^N$ and not only for a reduced solution!

Machine learning in model order reduction

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- ▶ Observation: Only coefficients are required to characterize the reduced solution!
- ▶ Idea [Hesthaven/Ubbiali'18]: Approximate coefficients by machine learning:

$$\tilde{\alpha}_i(\mu) \approx \alpha_i(\mu) \quad \implies \quad \tilde{y}_\mu^N = \sum_{i=1}^N \tilde{\alpha}_i(\mu) x_i \approx y_\mu^N$$

Apply error estimator η_μ of the reduced basis model to machine learning approximation:

$$\| \tilde{y}_\mu^N - y_\mu \| \leq \eta_\mu(\tilde{y}_\mu^N)$$

⇒ Error certification for the machine learning result!

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⇒ Error certification for the machine learning result!

- ▶ Different machine learning techniques are applicable, such as deep neural networks, kernel methods, Gaussian process regression, etc.
- ▶ Error estimate still holds due to connection to reduced basis model.
- ▶ Reduced coefficients serve as training data (no high-dimensional solutions required to obtain training data once reduced basis is built).

Adaptive model hierarchies combining multiple models

Adaptive model hierarchy for parametrized problems

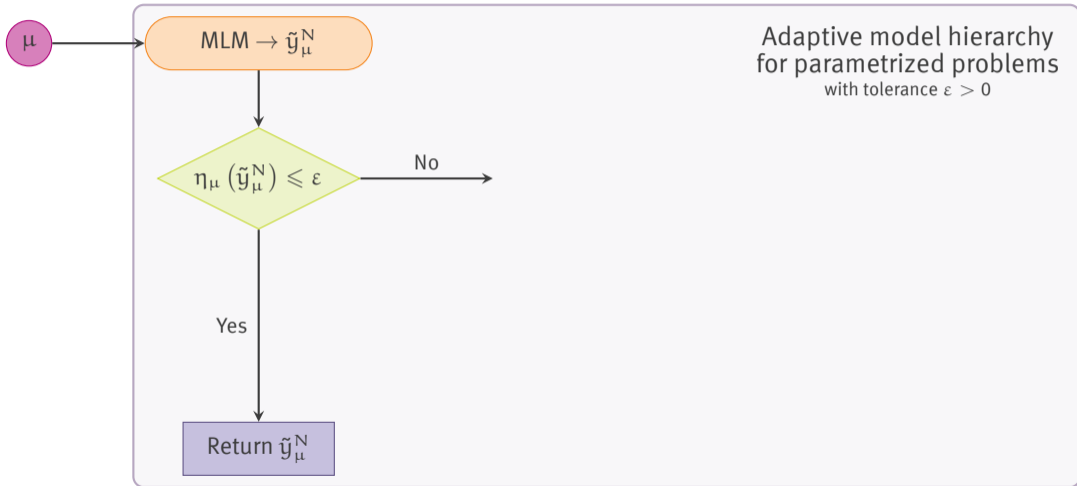
Three stages: Reduced basis and machine learning models

μ

Adaptive model hierarchy
for parametrized problems
with tolerance $\varepsilon > 0$

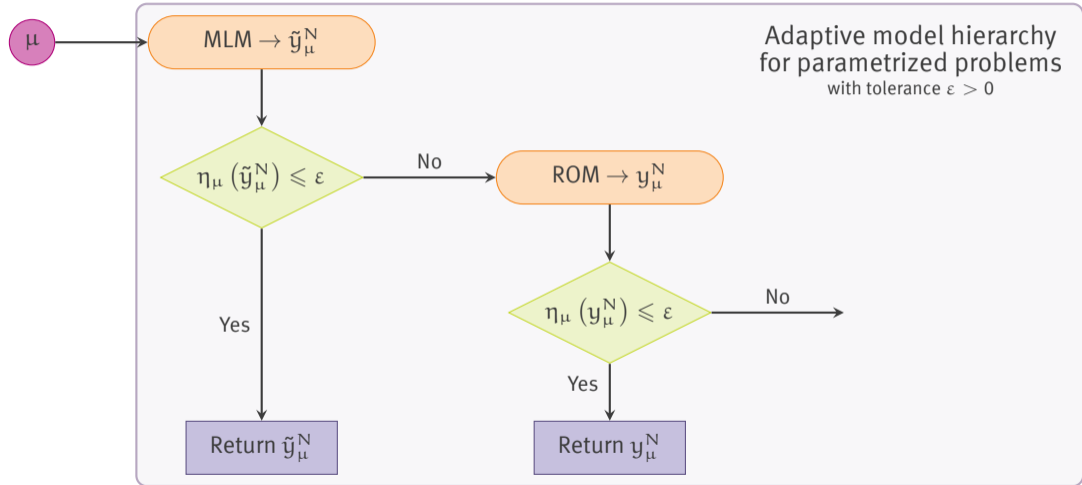
Adaptive model hierarchy for parametrized problems

Three stages: Reduced basis and machine learning models



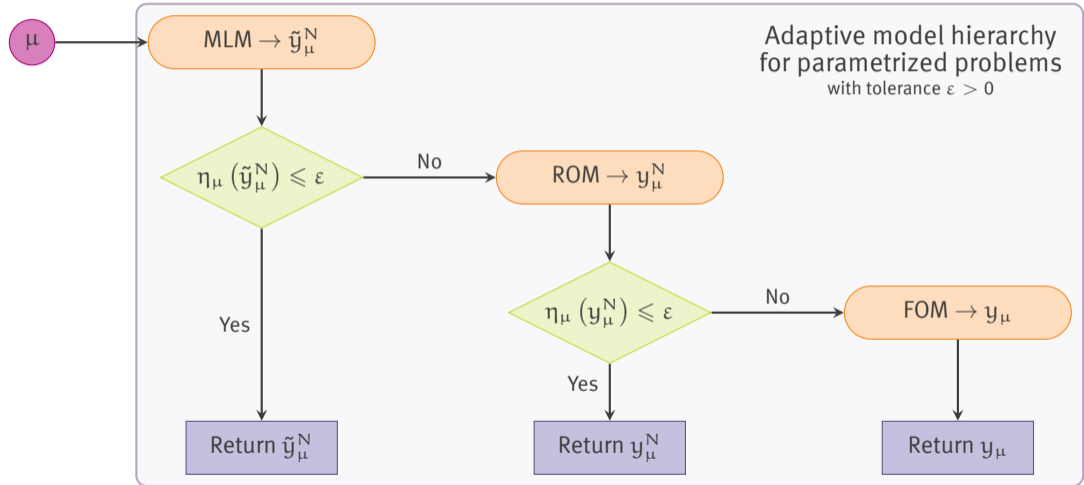
Adaptive model hierarchy for parametrized problems

Three stages: Reduced basis and machine learning models



Adaptive model hierarchy for parametrized problems

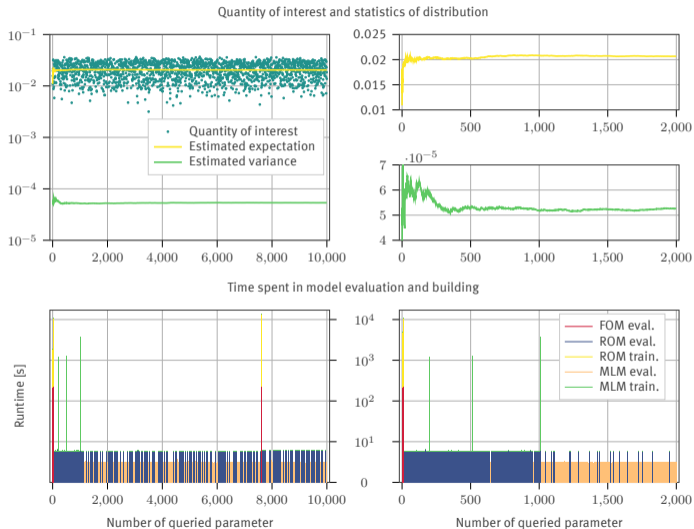
Three stages: Reduced basis and machine learning models



Numerical experiments and results

Parabolic partial differential equations: Heating of a building

Results of the model hierarchy

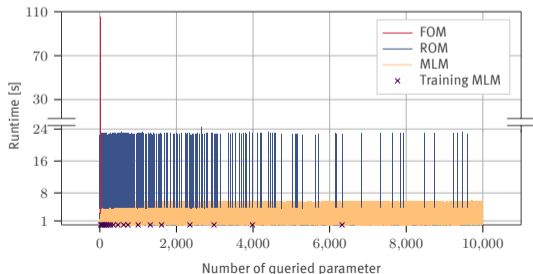


Optimal control problems: Baking cookies

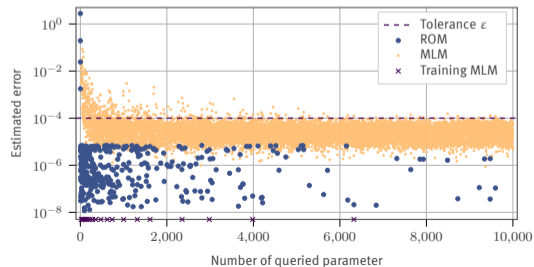
Results of the model hierarchy

| Model | Number of solves | Number of error estimates | Total time for error est. and solving [s] | Average time for error est. and solving per solve [s] |
|-------|------------------|---------------------------|---|---|
| FOM | 4 | — | 330.31 | 82.58 |
| ROM | 412 | 416 | 7,653.35 | 18.58 |
| MLM | 9,584 | 10,000 | 56,776.25 | 5.92 |

Time spent in model evaluation



Evaluations of the different models with error estimates



Thank you for your attention!





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